

MAAP-011451-DIE

Rev. V1

Features

- · 4 Stage Power Amplifier for E-Band
- 20 dB Gain
- 8 dB Input and Output Match
- 27 dBm Saturated Output Power
- 31 dBm OIP3
- · Variable Gain with Adjustable Bias
- Integrated Detector
- 2790 × 1950 × 50 µm Bare Die
- RoHS* Compliant

Applications

Point to Point

Description

The MAAP-011451-DIE is a bare die power amplifier. This device operates from 71 - 86 GHz. The amplifier provides 20 dB small signal gain, 27 dBm output power and 31 dBm Output Third Order Intercept Point (OIP3). An integrated temperature compensated power detector is on-chip. The input and output are matched to 50 Ω with bond wires to external board.

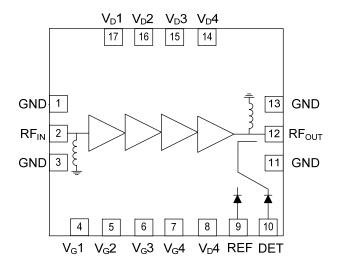
This amplifier is designed for use as a power amplifier stage in transmit chains and is ideally suited for E-band point-to-point radios. Each device is 100% RF tested to ensure performance compliance.

Ordering Information

Part Number	Package
MAAP-011451-DIE	Vacuum Release Gel Pak ¹

^{1.} Die quantity varies.

Functional Schematic



Bond-pad Configuration

Pin#	Function	Pin#	Function
1	Ground ²	10	DET
2	RF _{IN}	11	Ground ²
3	Ground ²	12	RF _{OUT}
4	V _G 1	13	Ground ²
5	V _G 2	14	V _D 4
6	V_G3	15	V _D 3
7	V _G 4	16	V _D 2
8	V _D 4	17	V _D 1
9	REF	18	Ground ³

- 2. These pads are internally connected to ground.
- The backside of the die must be connected to RF, DC and thermal ground.

^{*} Restrictions on Hazardous Substances, compliant to current RoHS EU directive.



Electrical Specifications: I_{DQ} = 760 mA (Full Bias), V_D = 4 V, Z_0 = 50 Ω , T_A = 25°C

Parameter	Test Conditions	Units	Min.	Тур.	Max.
Gain	71 - 76 GHz 76 - 81 GHz 81 - 86 GHz	dB	17 15 15	21 18 17	_
Input Return Loss	71 - 76 GHz 76 - 81 GHz 81 - 86 GHz	dB	_	8 10 5	_
Output Return Loss	71 - 76 GHz 76 - 81 GHz 81 - 86 GHz	dB	_	7 10 10	_
Noise Figure	71 - 76 GHz 76 - 81 GHz 81 - 86 GHz	dB	_	7 7 7	_
OIP3	P _{IN} = -5 dBm/tone, 11 MHz Tone Spacing 71 - 76 GHz 76 - 81 GHz 81 - 86 GHz	dBm	_	32 31 31	_
Output P1dB	71 - 76 GHz 76 - 81 GHz 81 - 86 GHz	dBm	_	26 25 25	_
P _{SAT}	71 - 76 GHz 76 - 81 GHz 81 - 86 GHz	dBm	25 25 25	28 26 26	_
Efficiency		%	_	12 6 6	_
	@ P _{SAT} 71 - 76 GHz 76 - 81 GHz 81 - 86 GHz			15 9 9	



Electrical Specifications: I_{DQ} = 460 mA (Reduced Bias), V_D = 4 V, Z_0 = 50 Ω , T_A = 25°C

Parameter	Test Conditions	Units	Min.	Тур.	Max.
Gain	71 - 76 GHz 76 - 81 GHz 81 - 86 GHz	dB	_	17 14 14	_
Input Return Loss	71 - 76 GHz 76 - 81 GHz 81 - 86 GHz	dB	_	8 10 5	_
Output Return Loss	71 - 76 GHz 76 - 81 GHz 81 - 86 GHz	dB		6 8 8	_
Noise Figure	71 - 76 GHz 76 - 81 GHz 81 - 86 GHz	dB		7 7 7	_
OIP3	P _{IN} = -5 dBm/tone, 11 MHz Tone Spacing 71 - 76 GHz 76 - 81 GHz 81 - 86 GHz	dBm	_	29 29 29	_
Output P1dB	71 - 76 GHz 76 - 81 GHz 81 - 86 GHz	dBm	_	26 24 24	_
P _{SAT}	71 - 76 GHz 76 - 81 GHz 81 - 86 GHz	dBm	_	27 25 25	_
Efficiency	@ P1dB 71 - 76 GHz 76 - 81 GHz 81 - 86 GHz	%	_	9 6 6	_
	@ P _{SAT} 71 - 76 GHz 76 - 81 GHz 81 - 86 GHz			15 9 9	



Recommended Quiescent Bias Currents, All Drain Supply Voltages are +4 V

Bias	I _D 1 mA	I _D 2 mA	I _D 3 mA	I _D 4 mA	Total mA
Full Bias	120	120	200	320	760
Reduced Bias	70	70	120	200	460

Absolute Maximum Ratings^{4,5}

Parameter	Absolute Maximum	
Drain Voltage	+4.3 V	
Gate Bias Voltage	-1.5 V < V _G < +0.3 V	
Drain Current	1135 mA	
Input Power	20 dBm	
Junction Temperature ^{6,7}	+150°C	
Operating Temperature	-40°C to +85°C	
Storage Temperature	-55°C to +150°C	

- 4. Exceeding any one or combination of these limits may cause permanent damage to this device.
- MACOM does not recommend sustained operation near these survivability limits.
- Operating at nominal conditions with T_J ≤ +150°C will ensure MTTF >1 x 10⁶ hours .
- 7. Typical thermal resistance (Θ_{JC}) = 10.95°C/W. Junction Temperature (T_{JJ}) = Back Plate Temperature (T_{BP}) + Θ_{Jc} * (V*I).
 - a) For $T_{BP} = +25^{\circ}C$,

T_J = 58°C @ 4 V, 760 mA

b) For $T_{BP} = +85^{\circ}C$,

T_J = 118°C @ 4 V, 760 mA

Handling Procedures

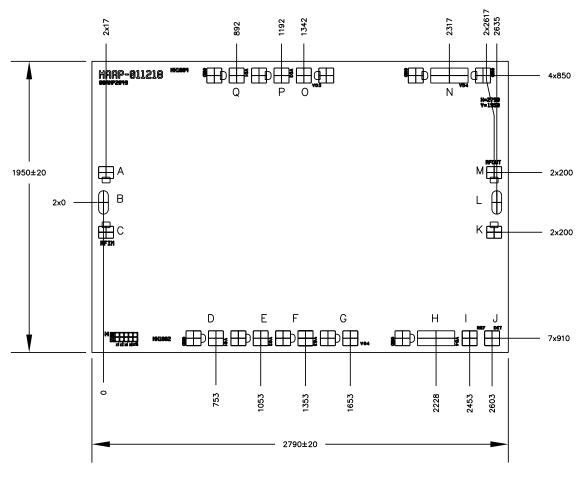
Please observe the following precautions to avoid damage:

Static Sensitivity

These Class 1B electronic devices are sensitive to electrostatic discharge (ESD) and can be damaged by static electricity. Proper ESD control techniques should be used when handling these devices.



Layout Dimensions^{8,9}



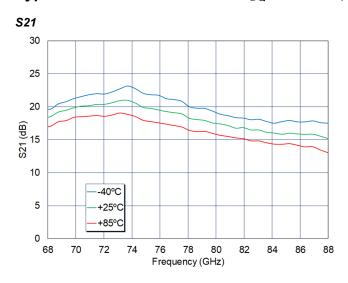
- 8. All units in the outline drawing are microns, with a tolerance of ± 5 µm, except for die exterior dimensions which are street-centre-to-centre minus the nominal kerf, ± 20 µm tolerance.
- 9. Die Thickness is 50 \pm 10 μ m.

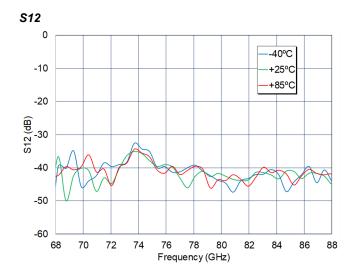
Bond Pad Opening Detail

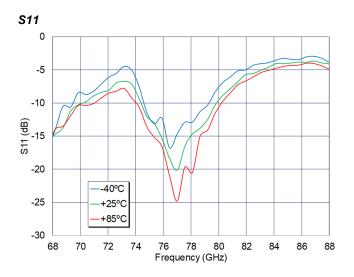
Pad	Size (x) µm	Size (y) µm
B, L	65	157
D,E,F,G,I,J,O,P,Q	100	100
H, N	250	100
A,C,K,M	100	80

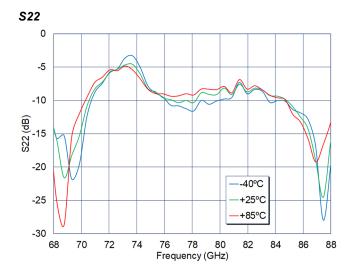


Typical Performance Curves: $I_{DQ} = 760 \text{ mA}$, $V_D = 4 \text{ V}$, Full Bias





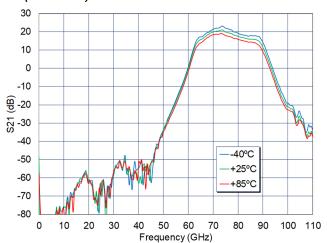




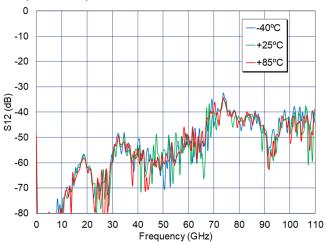


Typical Performance Curves: $I_{DQ} = 760 \text{ mA}$, $V_D = 4 \text{ V}$, Full Bias

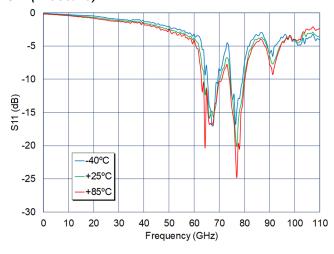
S21 (Wideband)



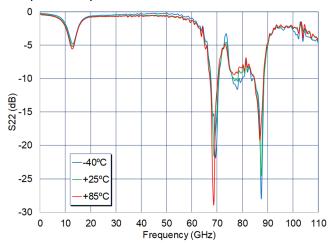
S12 (Wideband)



S11 (Wideband)

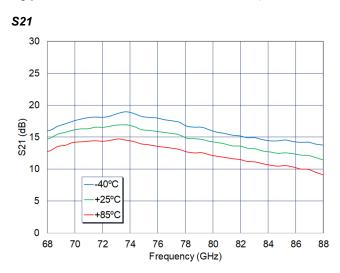


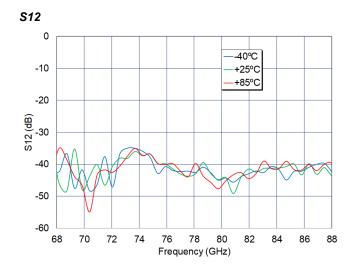
S22 (Wideband)

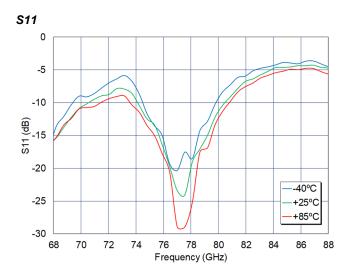


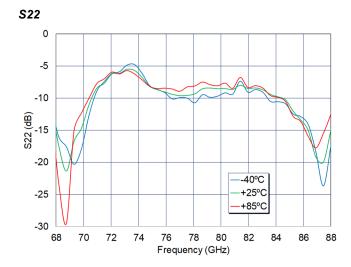


Typical Performance Curves: I_{DQ} = 460 mA, V_D = 4 V, Reduced Bias





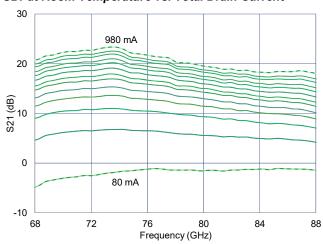




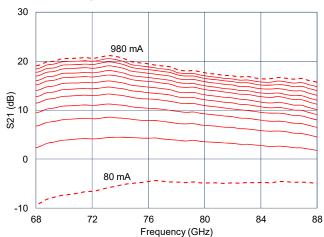


Typical Performance Curves: V_D = 4 V

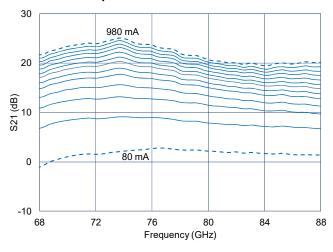
S21 at Room Temperature vs. Total Drain Current*



S21 at Hot Temperature vs. Total Drain Current*



S21 at Cold Temperature vs. Total Drain Current*

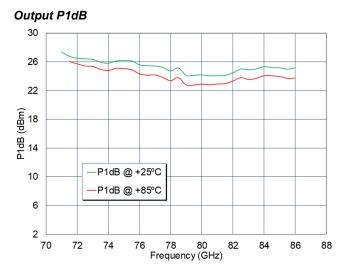


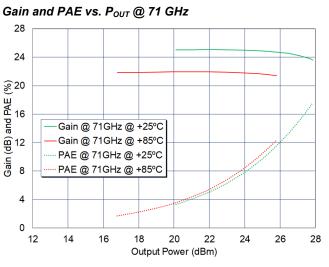
^{*}Total Drain currents were set at 80,150, 230, 300, 380, 460, 530, 610, 680, 760, 840, 910, and 980 mA.

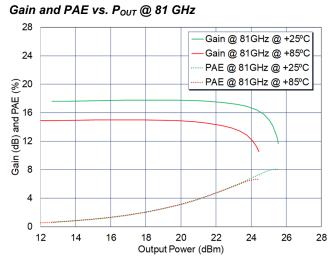


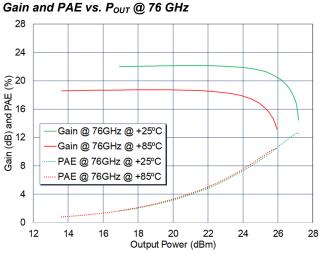
Typical Performance Curves: $I_{DQ} = 760 \text{ mA}$, $V_D = 4 \text{ V}$ (Full Bias)

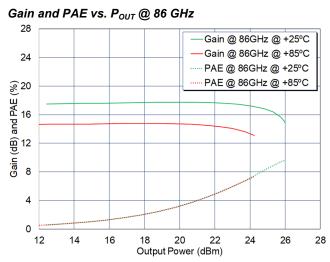
Saturated Power and PAE 30 26 22 PSAT @ +25°C PSAT (dBm) & PAE (%) PSAT @ +85°C PAE @ PSAT @ +25°C PAE @ PSAT @ +85°C 70 72 74 84 86 88 Frequency (GHz)











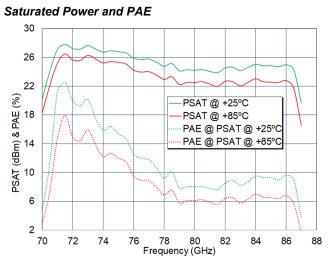
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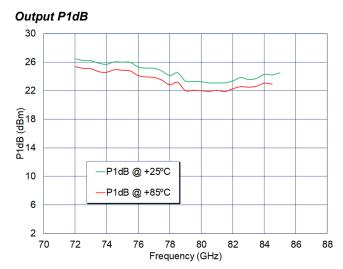
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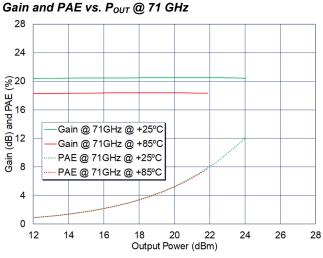
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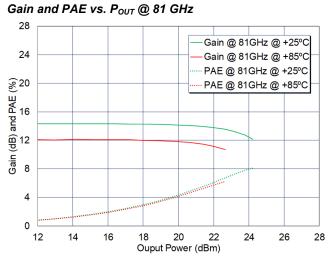


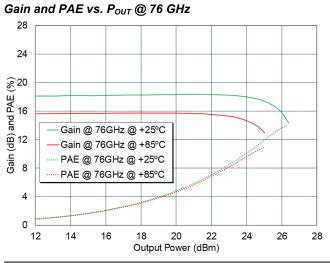
Typical Performance Curves: I_{DQ} = 460 mA, V_D = 4 V (Reduced Bias)

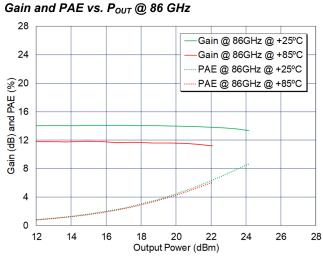












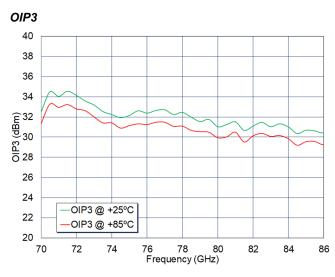
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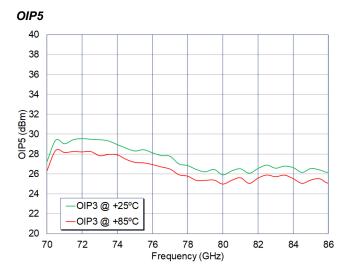
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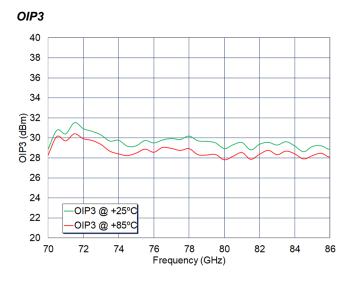


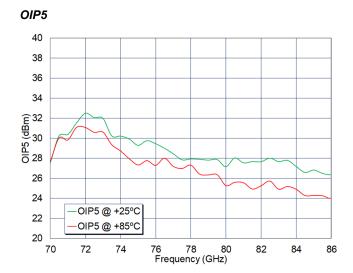
Typical Performance Curves: I_{DQ} = 760 mA, V_D = 4 V, Full Bias, RF P_{IN} = -5 dBm/tone





Typical Performance Curves: I_{DQ} = 460 mA, V_D = 4 V, Reduced Bias, RF P_{IN} = -5 dBm/tone





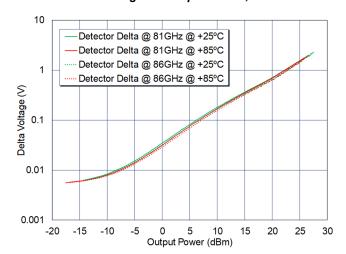


Typical Performance Curves: $I_{DQ} = 760 \text{ mA}$, $V_D = 4 \text{ V}$, Full Bias

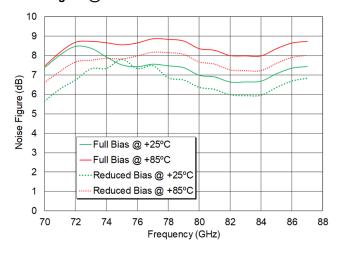
Detector Delta Voltage vs. Output Power, 71 - 76 GHz

10 Detector Delta @ 71GHz @ +25°C Detector Delta @ 71GHz @ +85°C Detector Delta @ 76GHz @ +25°C Detector Delta @ 76GHz @ +85°C Delta Voltage (V) 0.1 0.01 0.001 -20 -15 5 15 20 25 30 Output Power (dBm)

Detector Delta Voltage vs. Output Power, 81 - 86 GHz



Noise Figure @ Full and Reduced Bias





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Calibration Plane

All data was measured on die with 200 µm pitch probes. All data was measured with an ISS cal.

App Note [1] Biasing

All gates should be pinched-off ($V_G < -1 V$) before applying drain voltage ($V_D = 4 V$). Then the gate voltages can be increased until the desired quiescent drain current is reached in each stage. The recommended quiescent full bias is $V_D = 4 V$, $I_D = 120 MA$,

App Note [2] Bias Arrangement

Each DC pin $(V_D1,2,3,4)$ and $V_G1,2,3,4)$ needs to have bypass capacitors (120 pF and 10 nF) mounted as close to the MMIC as possible.

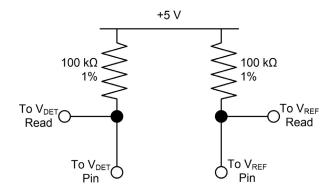
App Note [3] Common Gates and Drains

When biasing the device with only a single gate or drain source additional isolation is required between each stage. On the gate side a 10 Ω resistor should be placed in series and tied together in a star to a common supply. The drain side resistance should be reduced to less than 5 Ω to minimize any voltage drop across the resistor. Suitable bypass capacitors should still accompany each stage as per App Note [2].

To Stage 1 bias. To Stage 1 bias. To stage 2 bias. To stage 3 bias. To stage 4 bias.

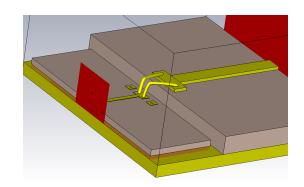
App Note [4] Detector Biasing Schematic

As shown in the schematic below, the power detector is biased by matched 100 k Ω resistors to a +5 V supply. The difference voltage between V_{DET} and V_{REF} pins can be obtained using a differencing circuit.



App Note [5] Wire Bonding

The loop height of the RF bonds should be minimized. Where the die is mounted above the PCB, it is recommended to use Reverse Ball-Stitch-on-Ball bonds (BSOB). If the die is mounted inside a cavity on the board, forward loop bonding may result in a lower loop height. V-shape RF bond with two wires (diameter = 20 μm) is recommended for optimum RF performance. RF bond wire length to be minimized to reduce the inductance effect. Simulations suggest no more than 300 μm . Substrate RF pad can be optimized to improve the microstrip to MMIC bond transition as shown in the example below. Please see App Note [6] for further details.





MAAP-011451-DIE

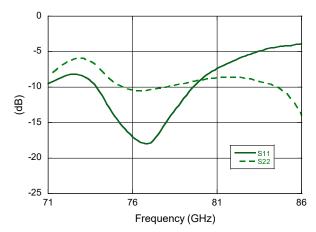
Rev. V1

App Note [6] RF Matching -

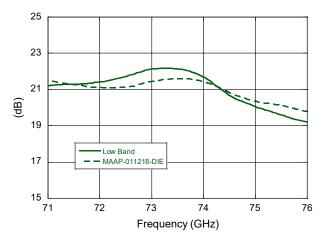
MAAP-011451 is designed to be a wideband RF power amplifier covering the 71 - 86 GHz band. By covering the full band, it enables customers to simplify BOM and circuitry for simple wideband performance. In cases where narrower band performance is preferred, external matching can be used to further optimise the return loss of the MMIC.

The board material used for matching was Isola Astra MT77. This has a dielectric constant $(D_k) = 3$ and a loss tangent (tan δ) of 0.0015. Simulations of the transition were performed in Analyst and can be provided on request. Transitions have been simulated to maintain return loss of -8 dB across the two bands of interest using Analyst.

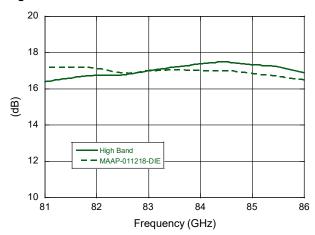
Return Loss



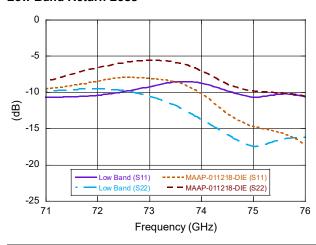
Low Band Gain



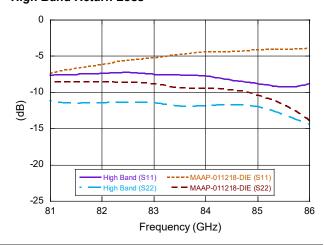
High Band Gain



Low Band Return Loss



High Band Return Loss



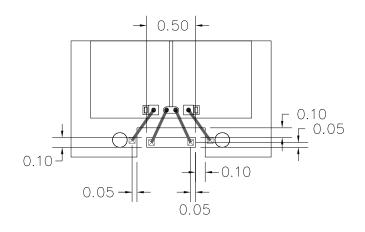
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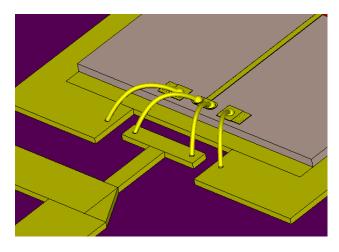
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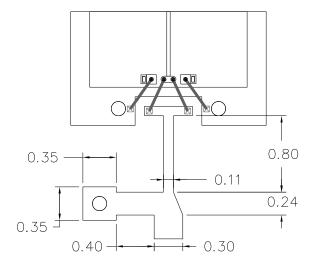


Input Dimensions Common to every optimisation

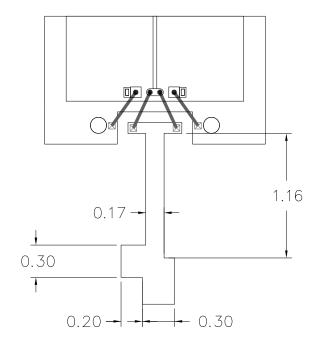




Low Band Optimisation Input Side



Low Band Optimisation Output Side

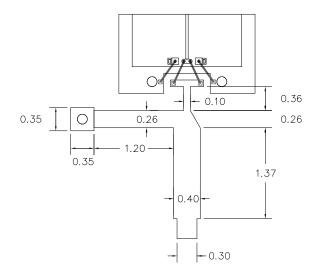




High Band Optimisation Input Side

0.35 0.36 0.40 0.70 0.35 0.30

High Band Optimisation Output Side



Power Amplifier, 0.5 W 71 - 86 GHz



MAAP-011451-DIE

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